



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Hsiao, Tommy C.; Hui, Angela T.; Ogle, Robert B.; Pham, Tuan Duc;

Plat, Marina V.; Ramsbey, Mark T.; Shen, Lewis

Assignee:

Advanced Micro Devices, Inc.

Title:

Polished Flash Process With Metal Gates And Improved Planarit

Serial No.:

09/430,366

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Examiner:

J. Chen

Group Art Unit:

2813

Docket No.:

M-7523 US

San Jose, California November 13, 2001

COMMISSIONER FOR PATENTS Washington, D. C. 20231

AMENDMENT

Dear Sir:

This is a response to the August 15, 2001 Office Action. Submitted herewith is also a Summary of Telephonic Interview with Examiner, which interview by Applicants' Attorney, J. Far-hadian, with Examiner Jack Chen on October 2001, pursuant to 37 CFR 1.133(b).

IN THE CLAIMS Summary of Telephonic Interview with Examiner, which memorializes the telephonic

The following is a clean version of the entire set of pending claims. In accordance with 37 CFR §1.121(c)(1)(ii), Attachment A provides marked up versions of the claims containing the newly introduced changes.

1. A method of making a flash memory cell including a substrate and a floating gate, the method comprising

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